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**EXPERIENCE WITH TESTING AND  
APPLICATION OF CICC at JAERI**

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at CICC meeting  
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## Outline of R&D for CICC at JAERI

At JAERI, R&D works of CICC and its coil are being carried for tokomak fusion machines.

### Stability

- \* stability margin
- \* limiting current
- \* lamp late limitation
- \* current sharing

### AC losses

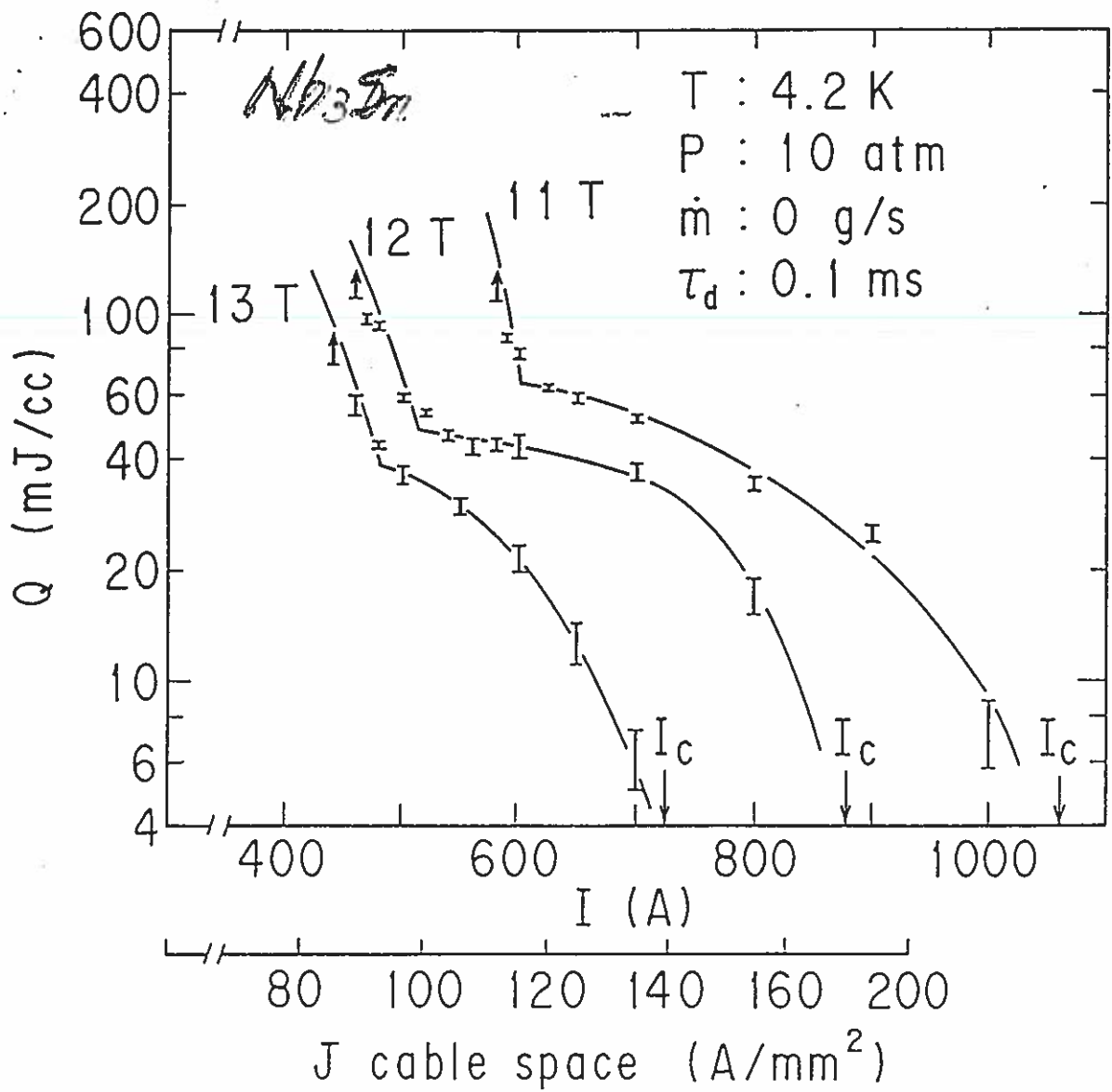
- \* inter-strand insulation
- \* cabling method

### Ic degradation

- \* conduit material selection

### Quench phenomenon

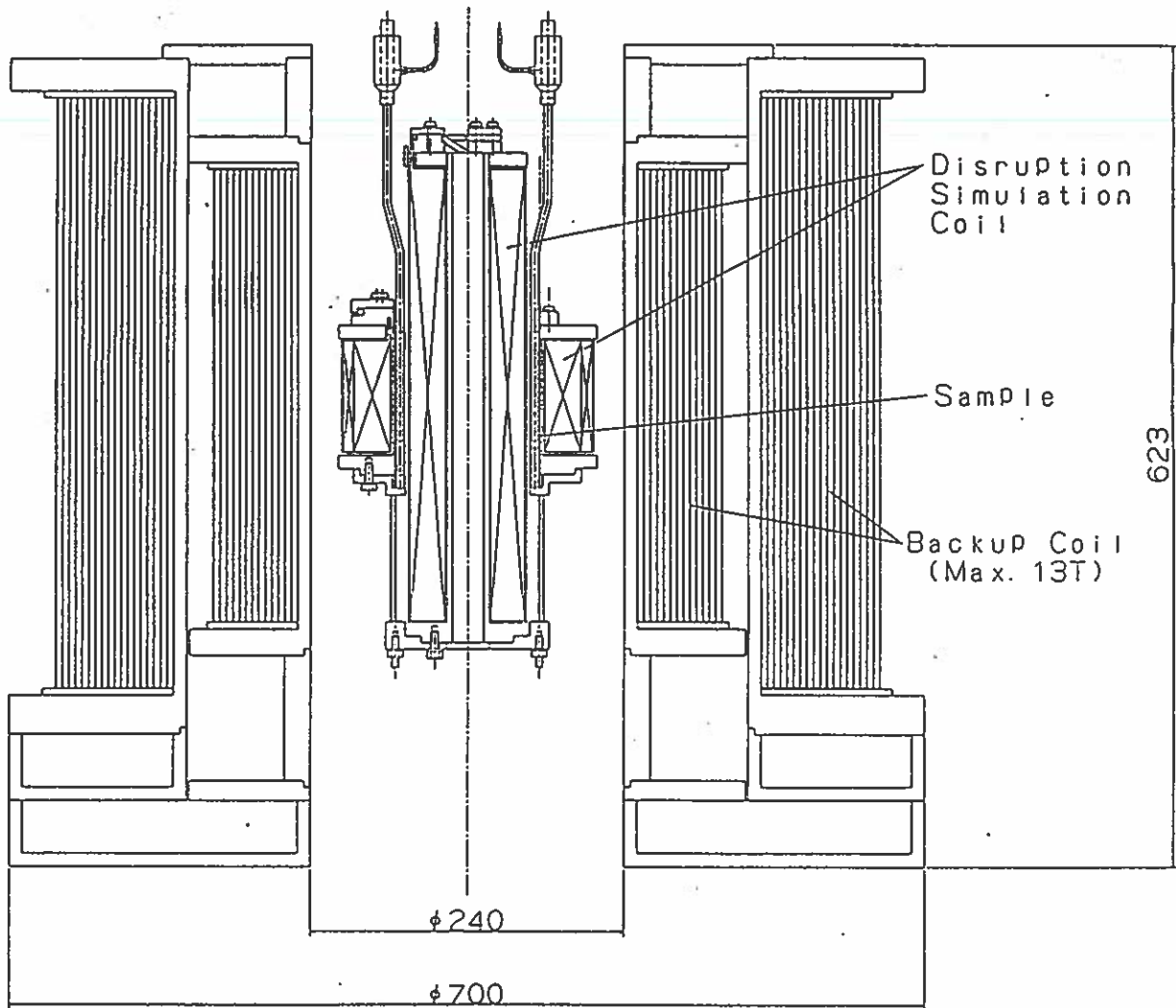
- \* propagation velocity
- \* pressure rise
- \* temperature rise
- \* quench detection



$$I^2 = \frac{h \cdot S \cdot P (T_c - T_b)}{\rho}$$

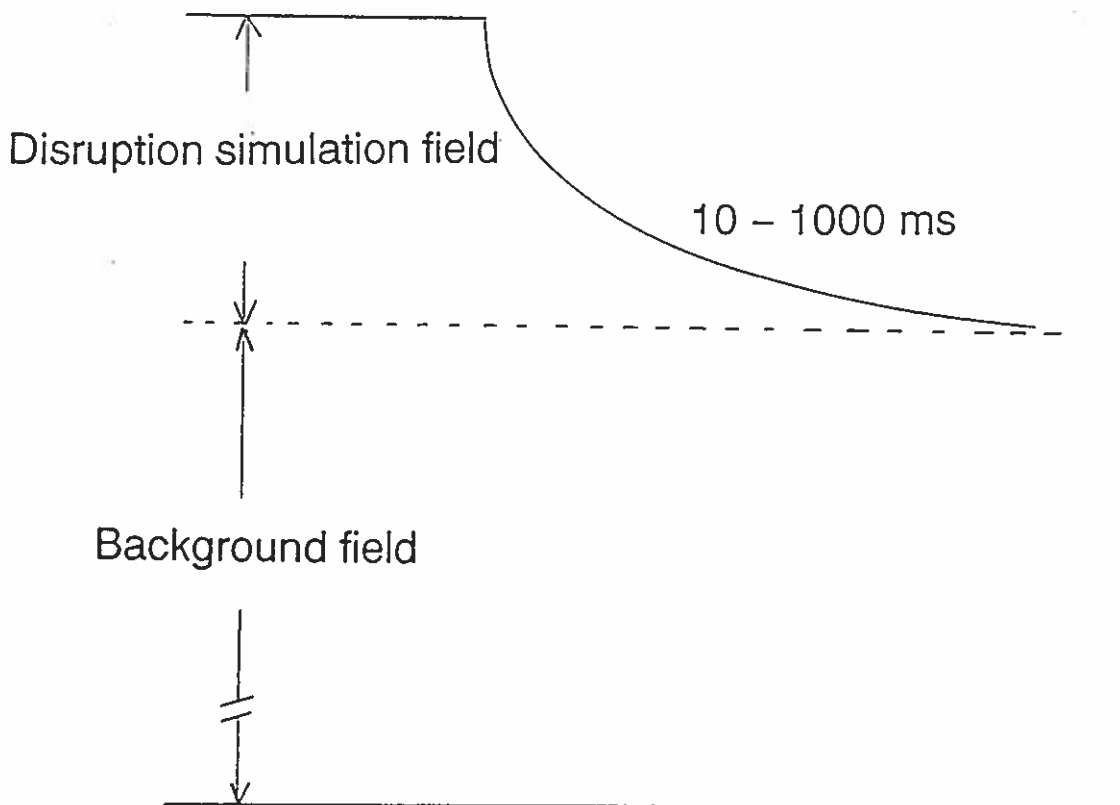
$$h = 1000 \text{ W/m}^2 \cdot \text{K}$$

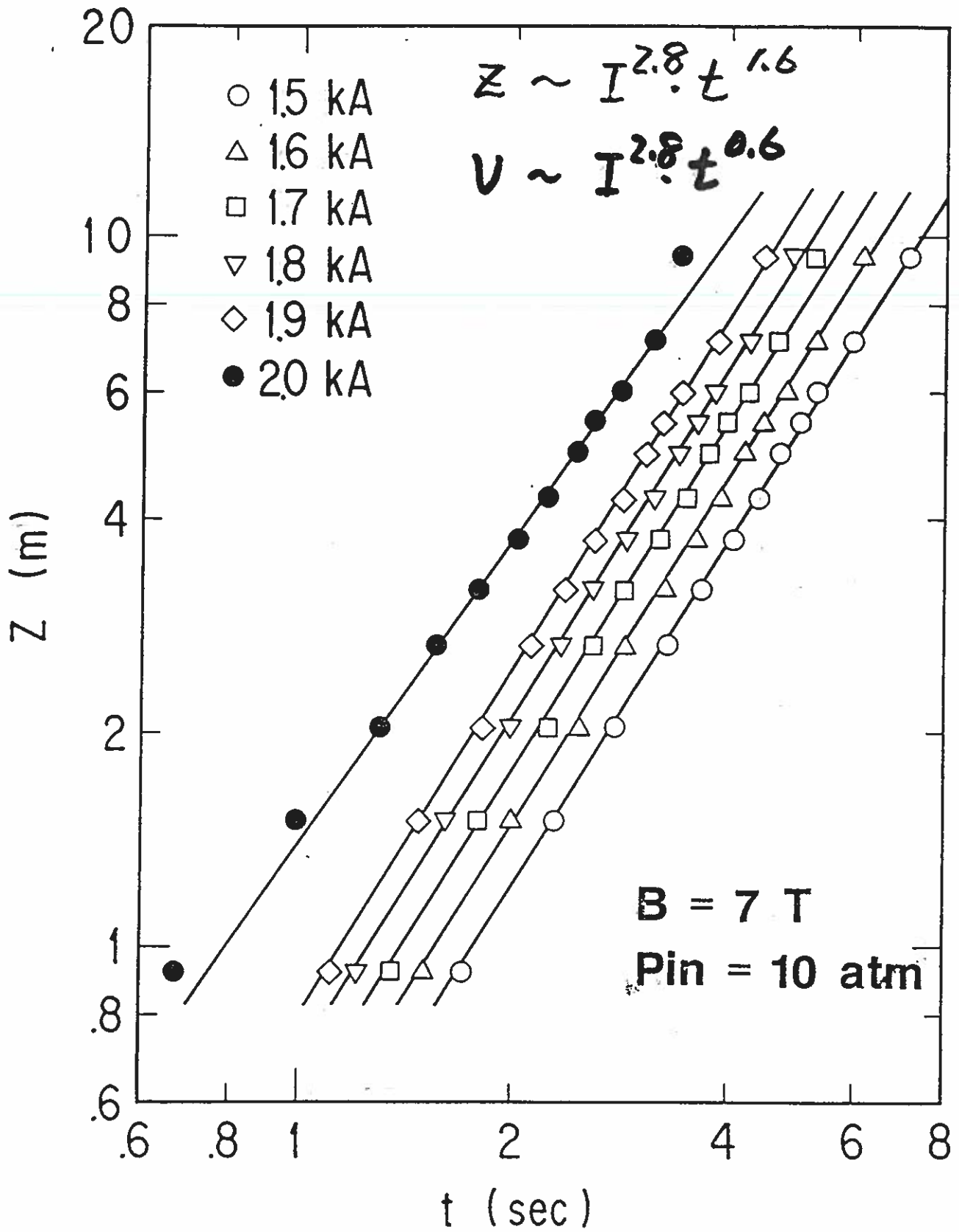
# CONFIGURATION OF THE APPARATUS



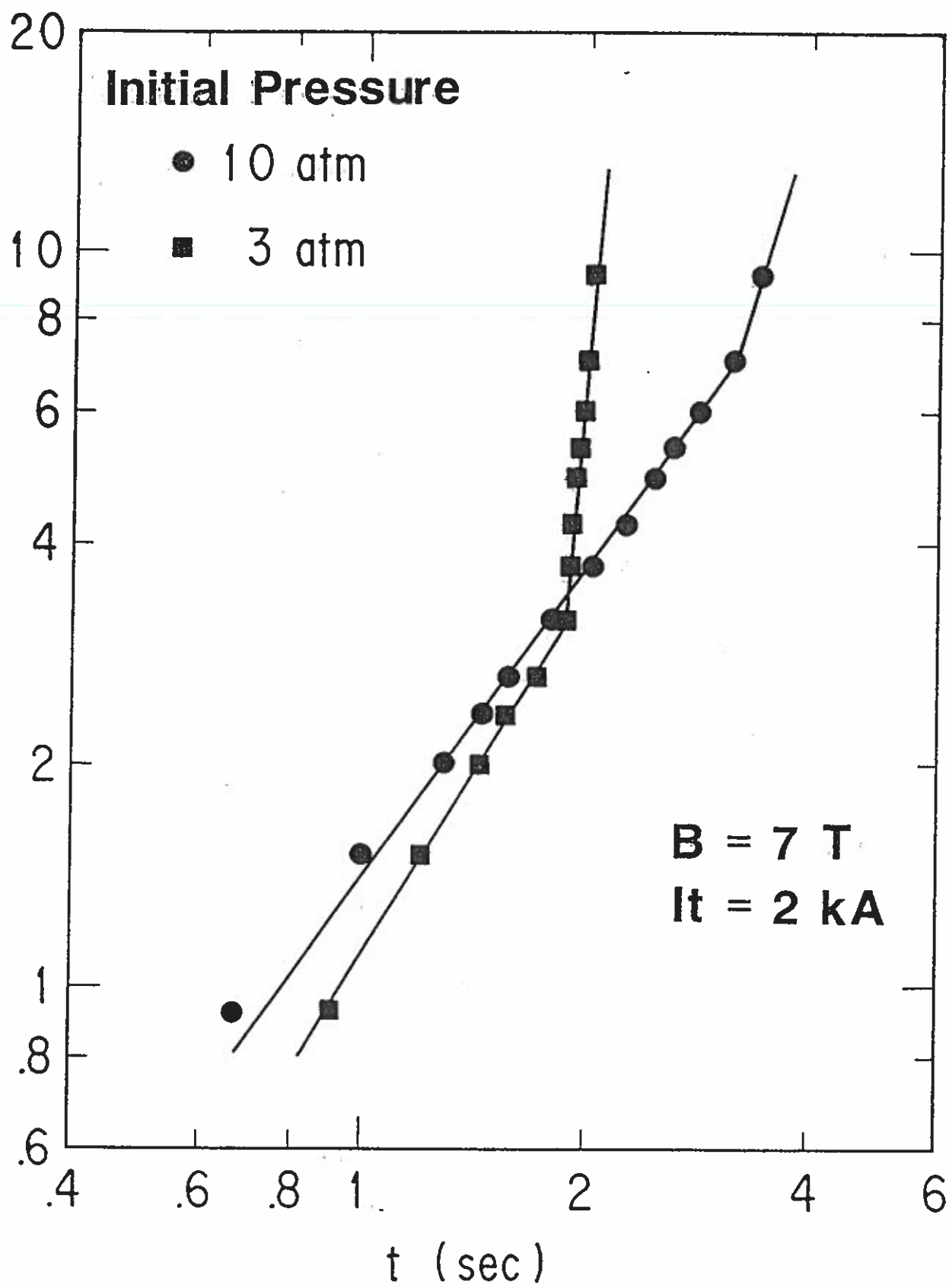
# TEST CONDITION

- \* Background field : 0 – 13 T
- \* Disruption simulation field : 0 – 2 T
- \* Disruption simulation changing time : 10 – 1000 ms
- \* Disruption simulation changing field : 20 – 2000 T/s





$V \sim t^a$





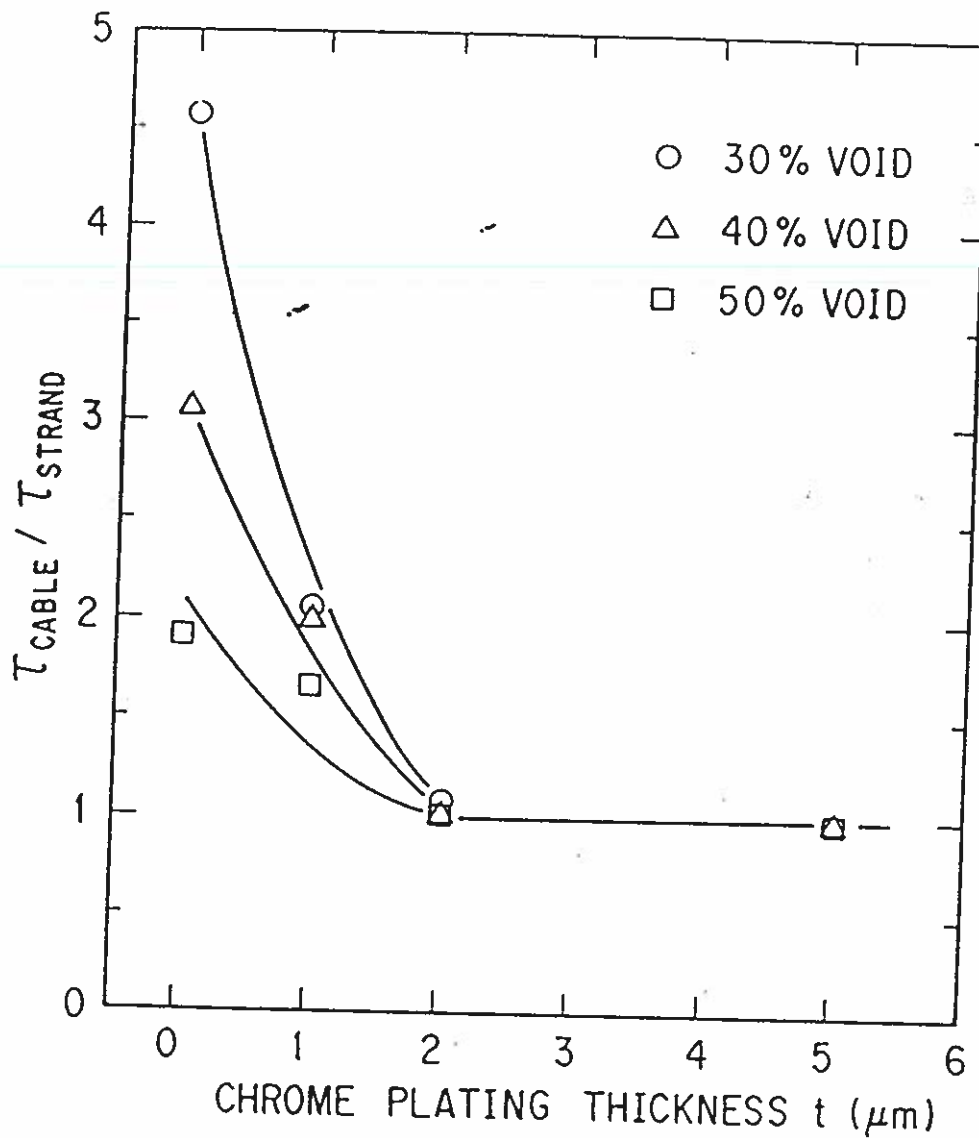
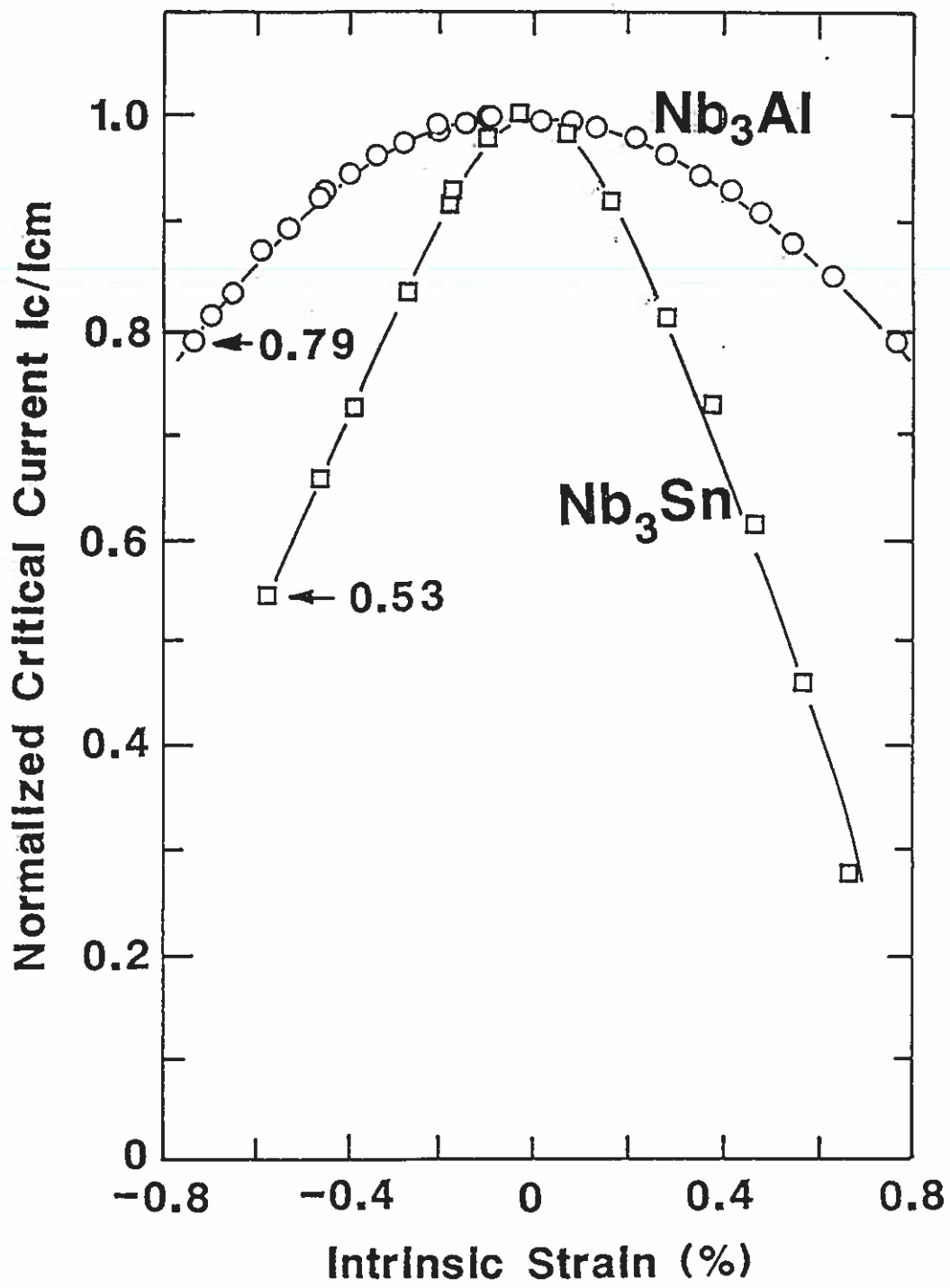
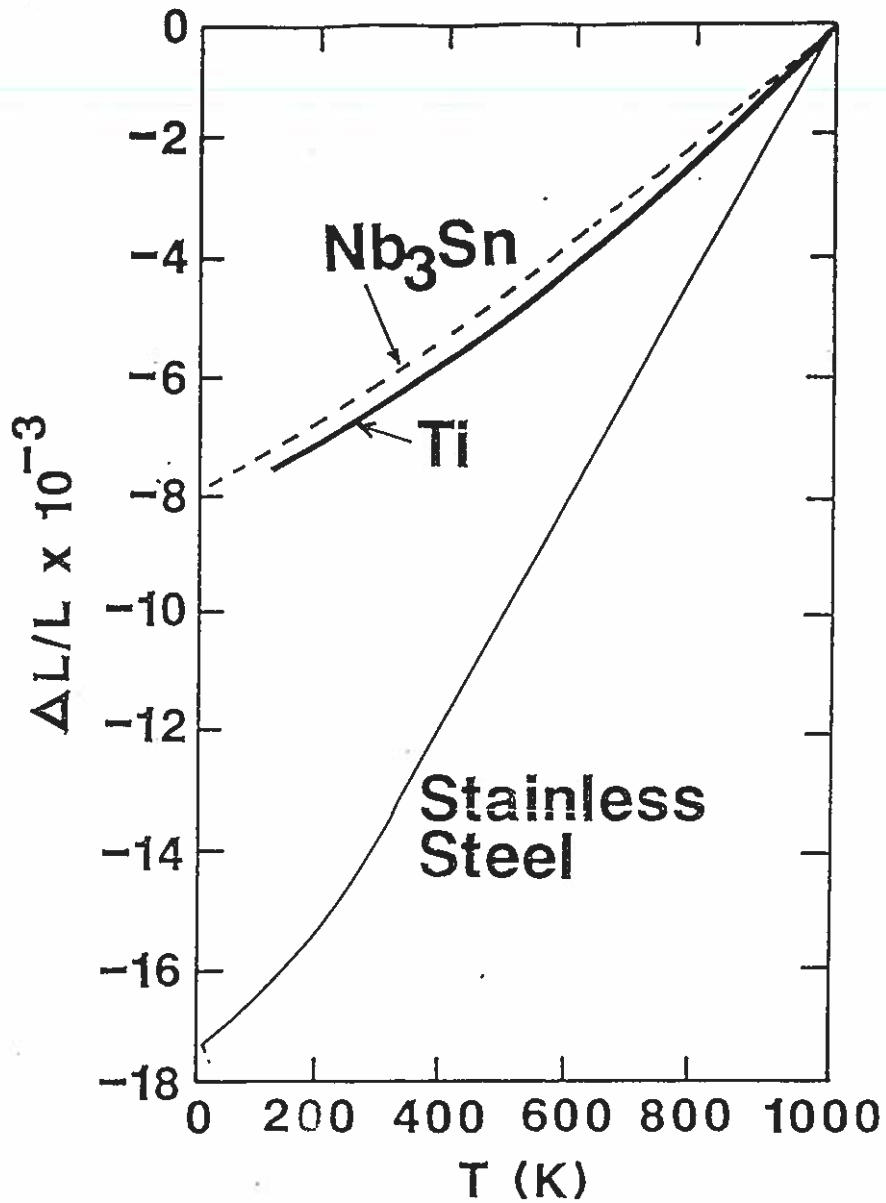


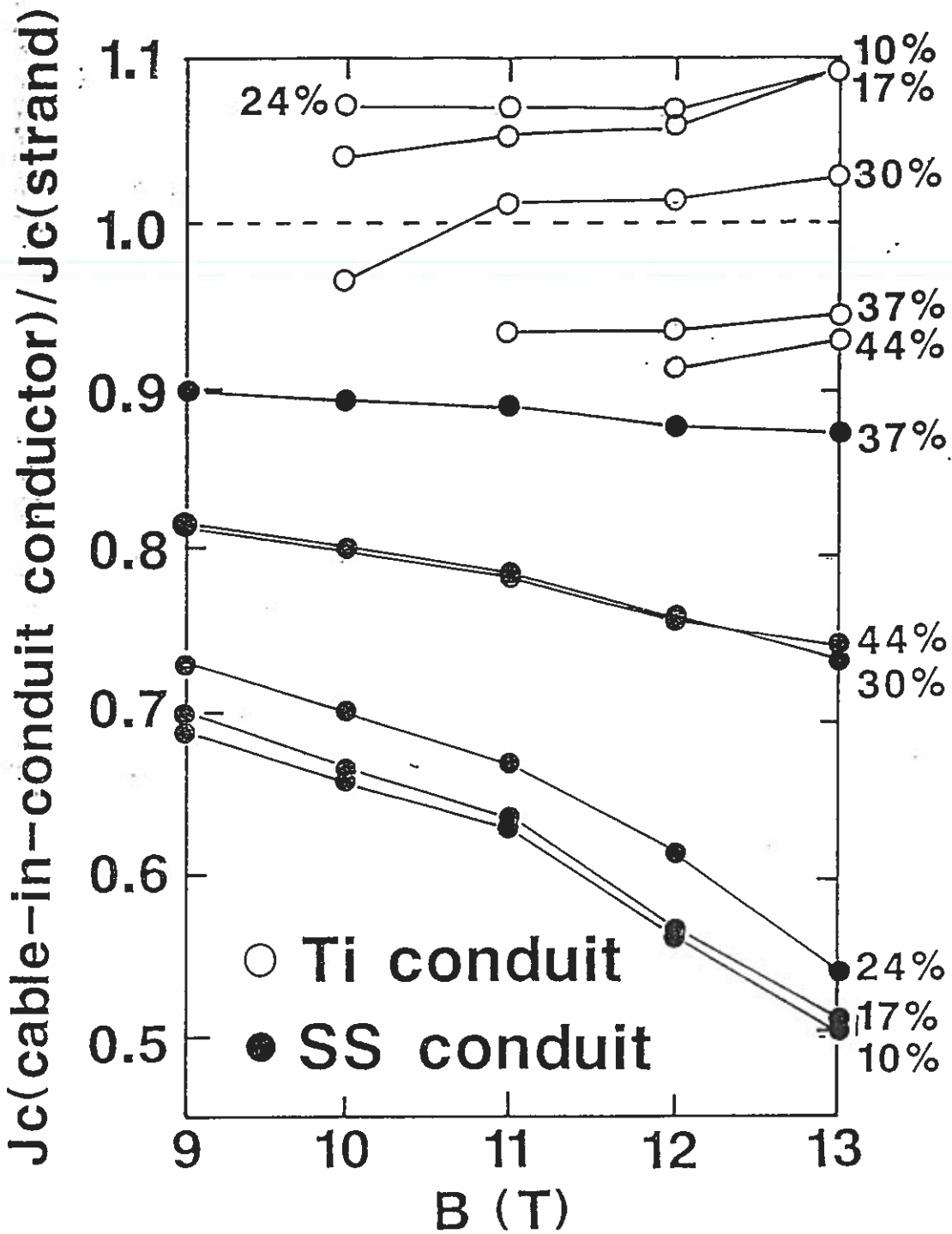
Fig. 6 Cable coupling time constant ( $\tau_{\text{cable}}$ ) normalized to the single strand coupling time constant ( $\tau_{\text{strand}}$ ) versus the chrome plating thickness.



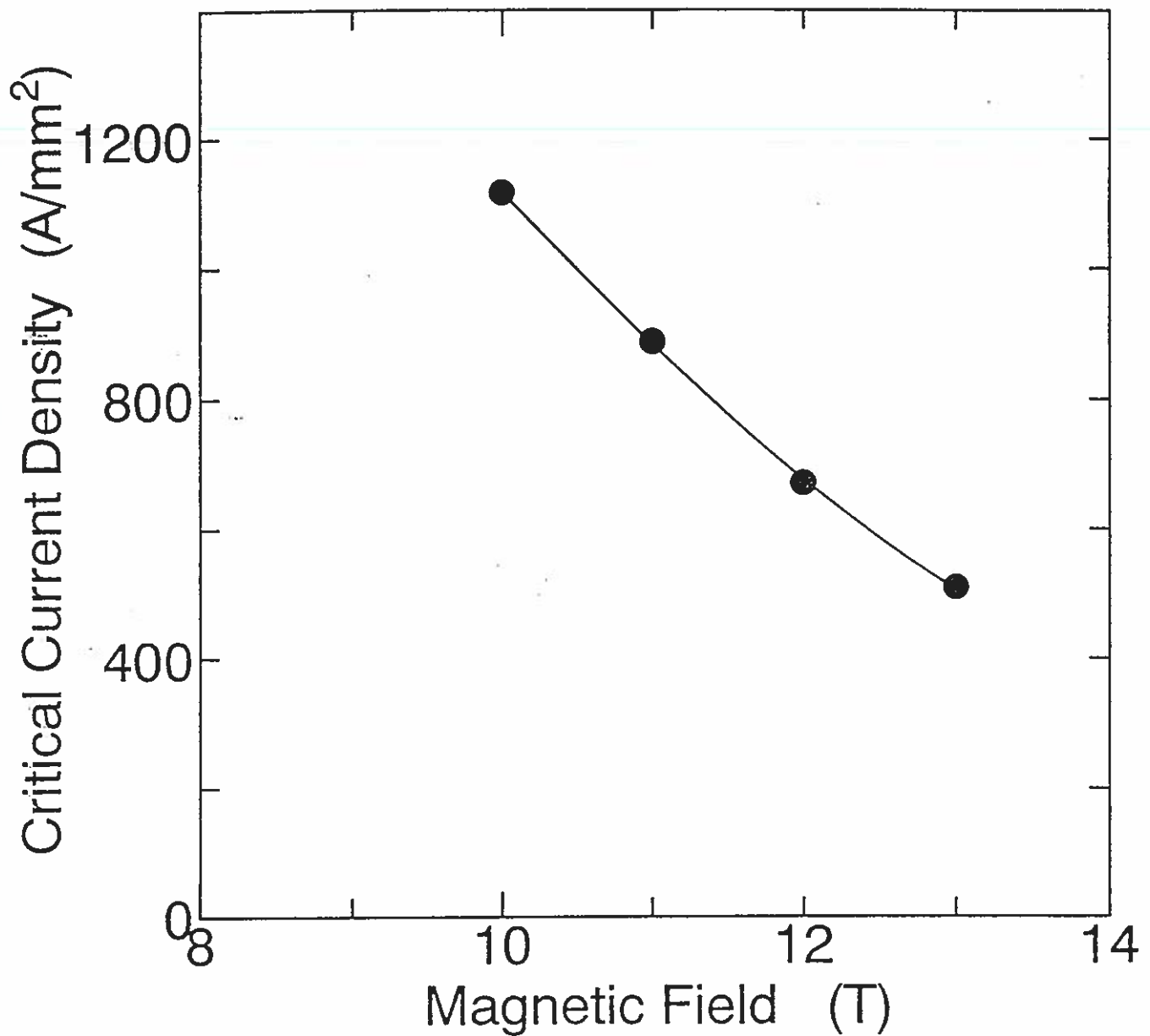
# CONDUIT DEVELOPMENT

## Thermal Expansion



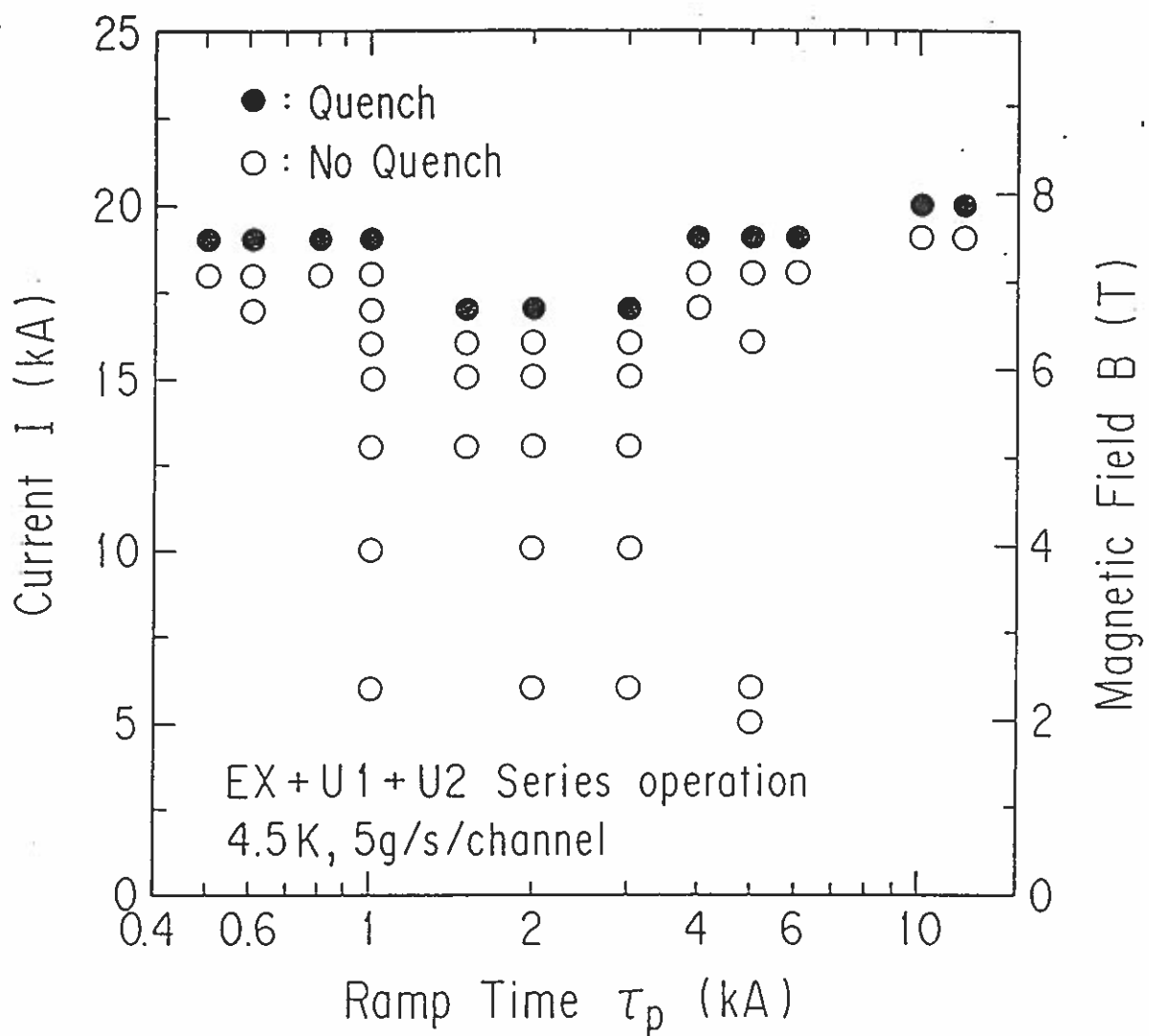


## Critical Current Density of Nb<sub>3</sub>Al Multifilamentary Cu-stabilized Strand

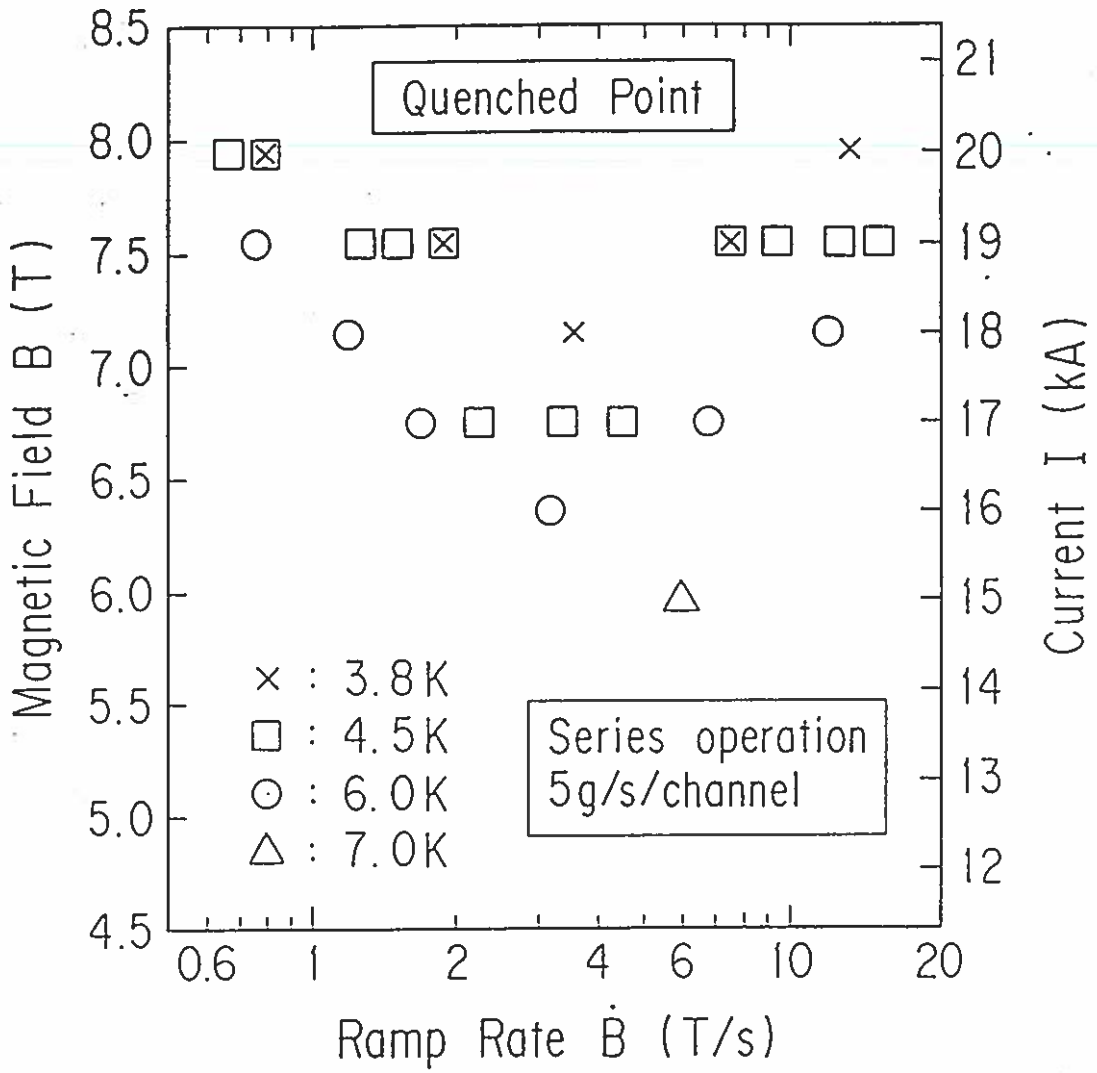


## 2. LAMP LATE LIMITATION

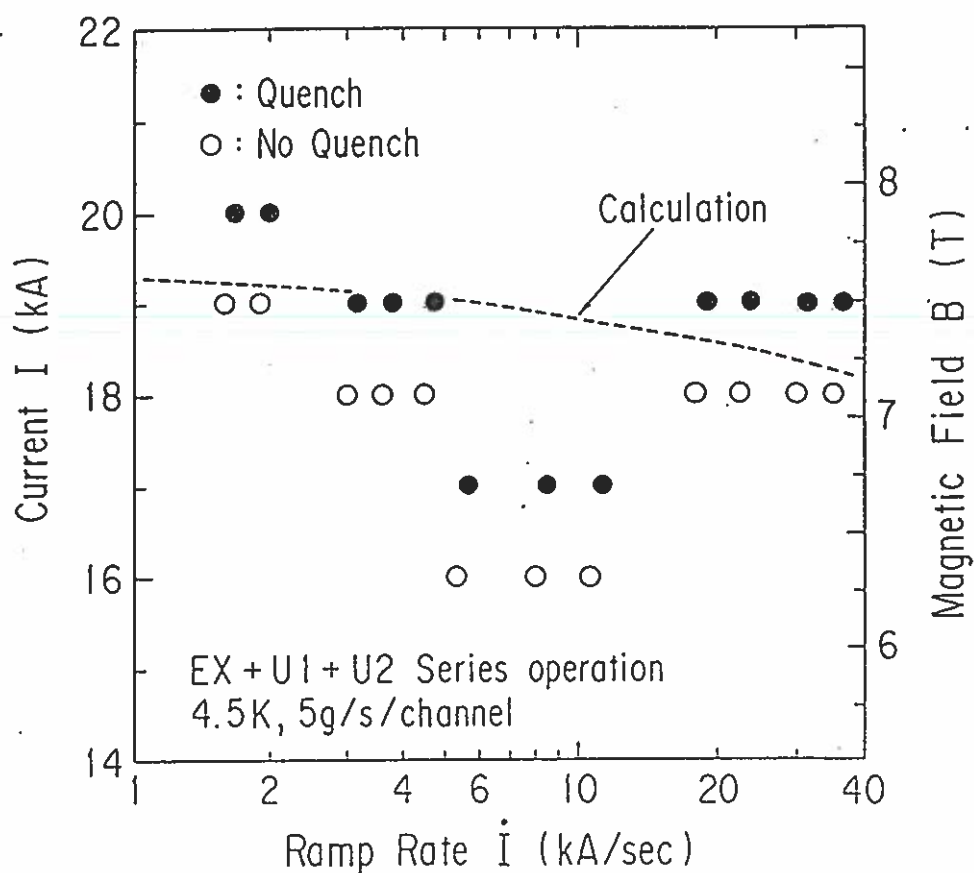
In the DPC-EX experiment, a lamp rate limitation has been measured.



# LAMP RATE LIMITATION(continued)



# LAMP RATE LIMITATION(continued)



$$I_{lim} \equiv \sqrt{I_0^2 + (\dot{I} + C_2)/4C_3^2} - (\dot{I} + C_2)/2C_3$$

$$B_{lim} \equiv \sqrt{c^2 I_0^2 + (c\dot{B} + cC_2)/4C_3^2} - (c\dot{B} + cC_2)/2C_3$$

$$I_0^2 \equiv \frac{(T_{co} - T_{bo})hsp}{\rho}$$

$$C_1 \equiv \frac{1}{mb} (T_{co} - T_{bo})$$

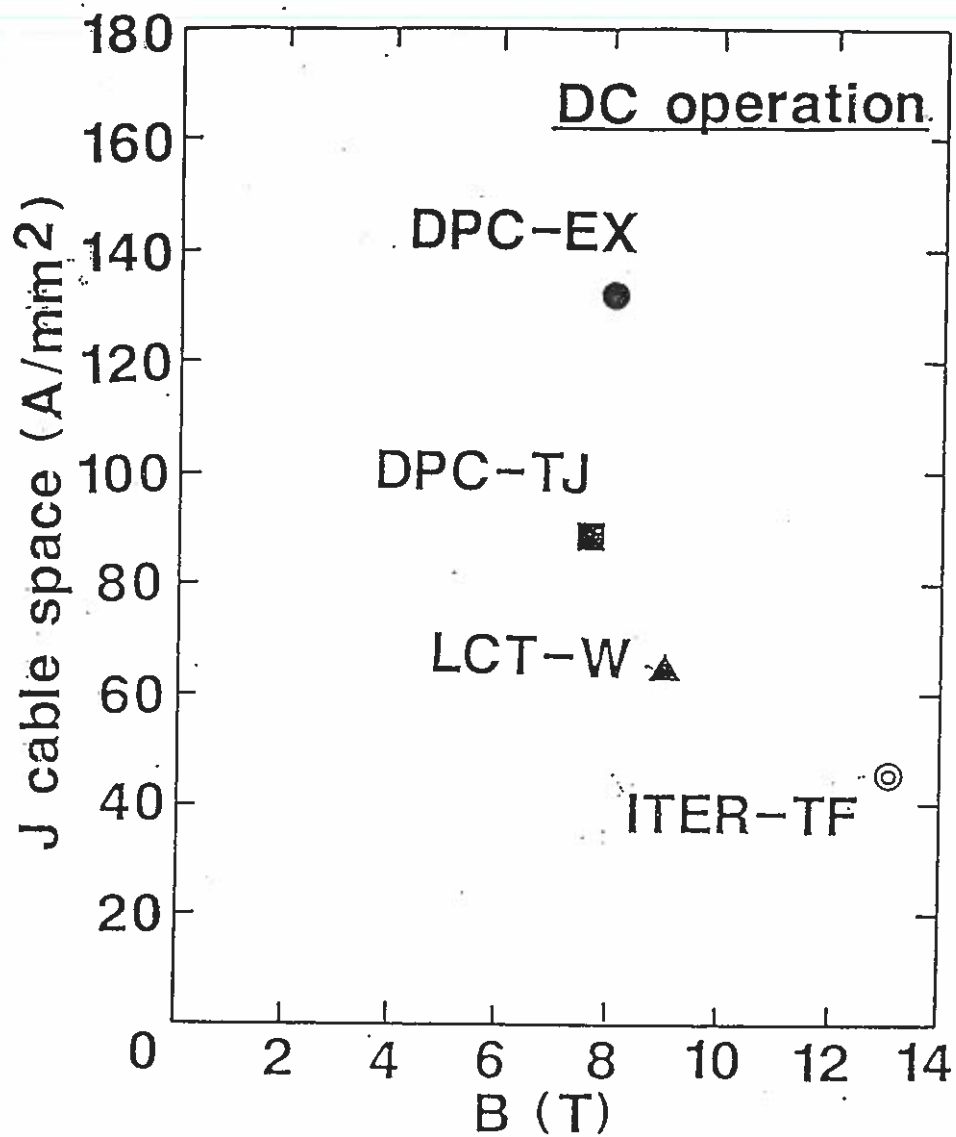
$$C_2 \equiv \frac{cg + ma}{mb}$$

$$C_3 \equiv \frac{\rho}{mbhsp}$$



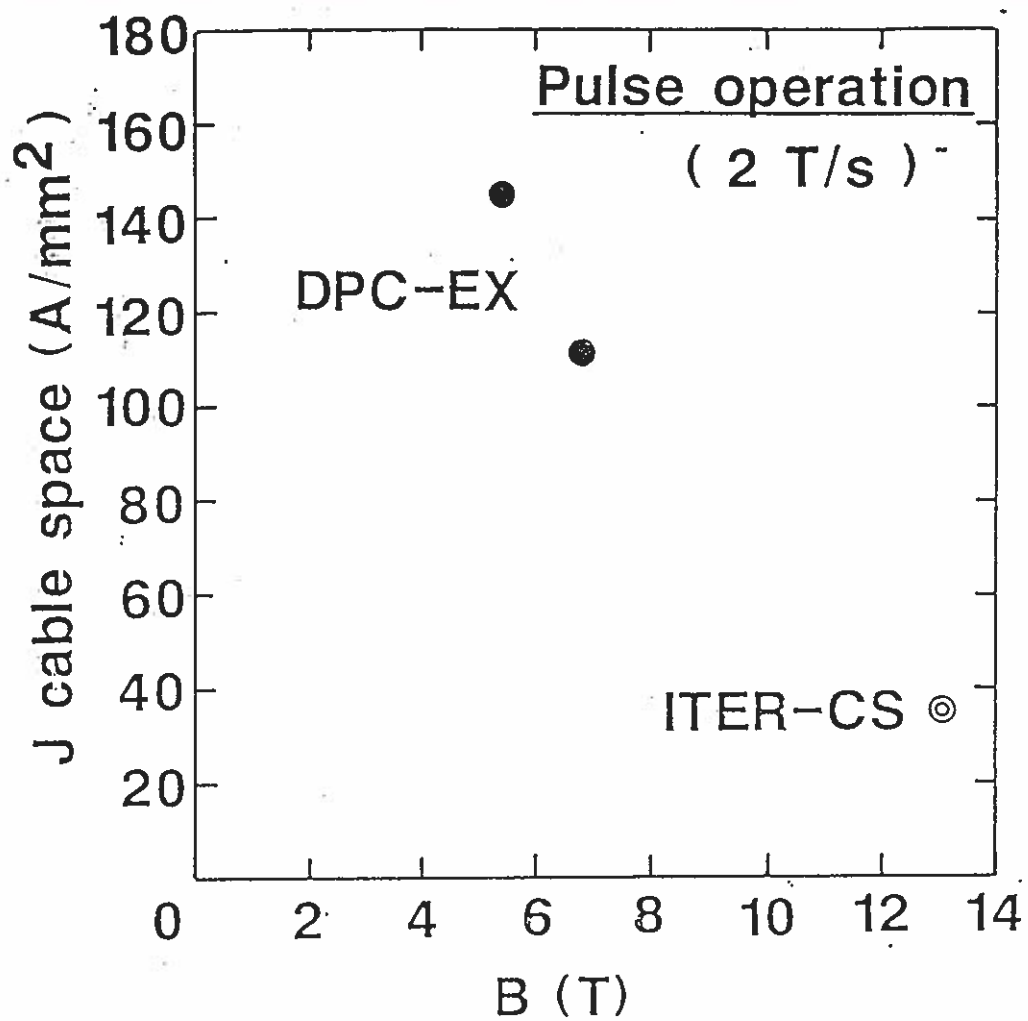
### 3. CURRENT DENSITY IN CABLE SPACE ACHIEVED IN COIL

DC Operation

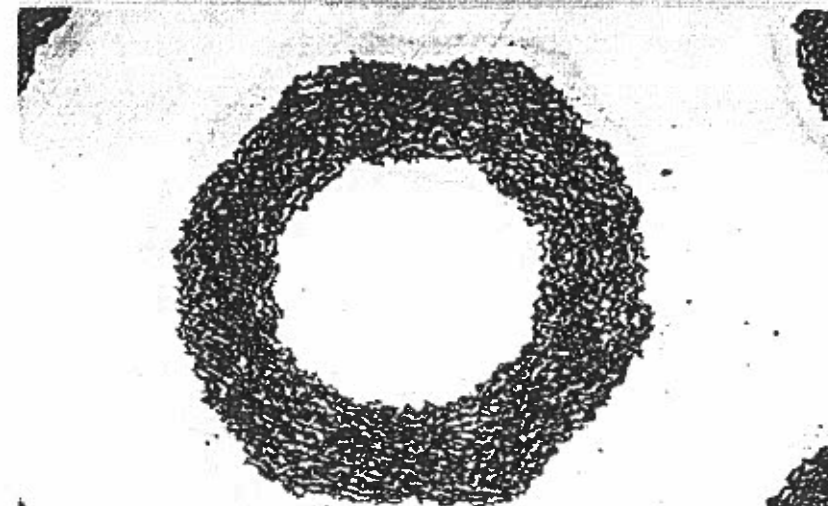
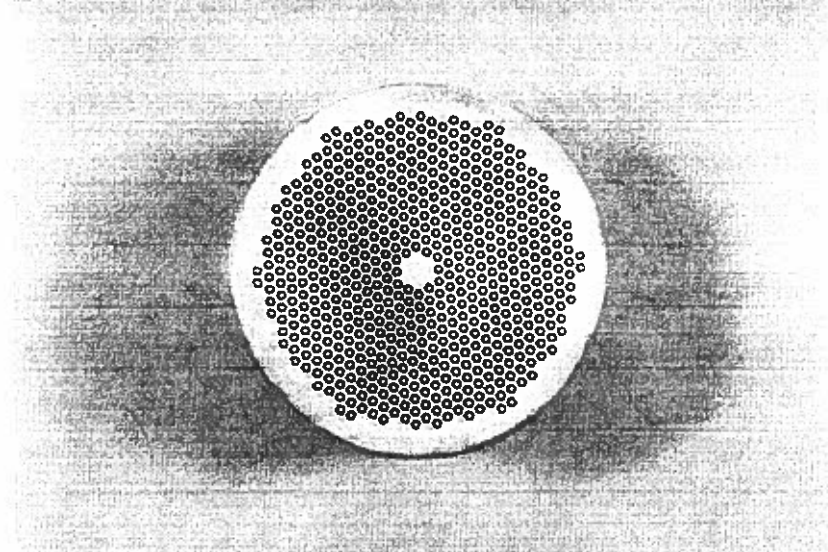
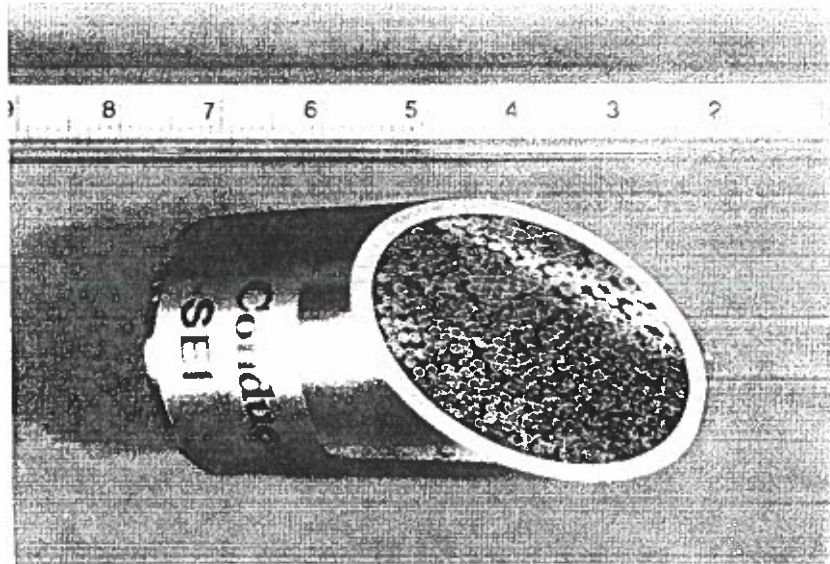


### 3. CURRENT DENSITY IN CABLE SPACE ACHIEVED IN COIL

Pulse Operation

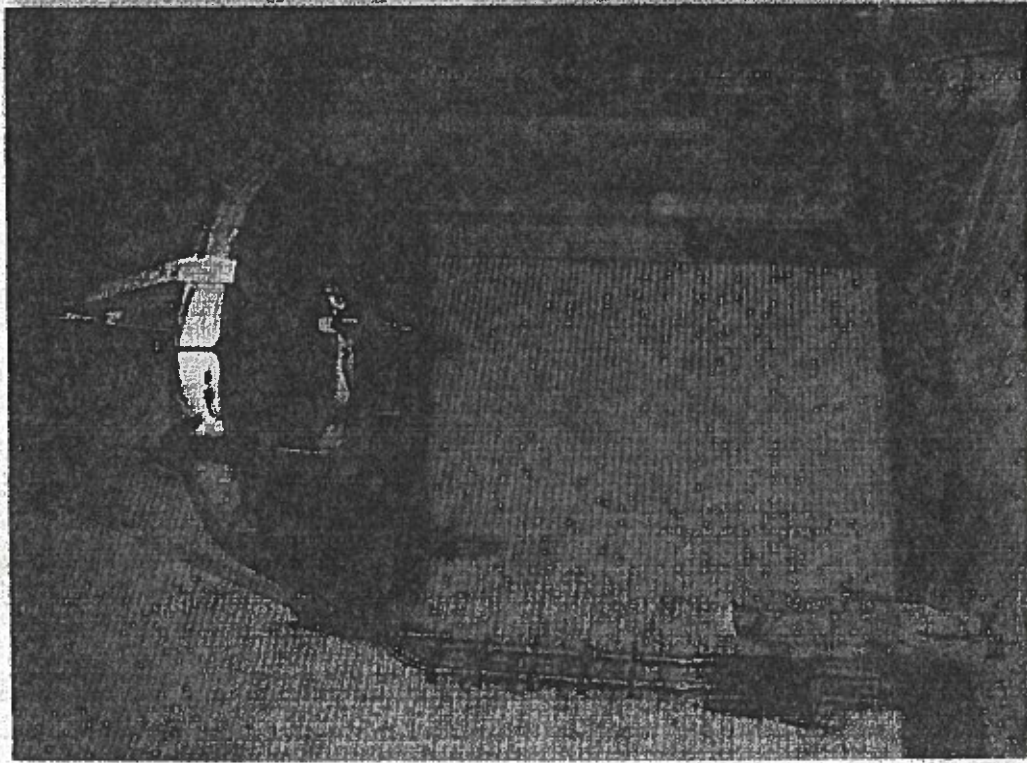


# 40 kA Nb<sub>3</sub>Al CONDUCTOR





# DPC-EX COIL



WINDING METHOD	2 DOUBLE PANCAKES (REACT and WIND)
COOLING METHOD	FORCED FLOW COOLING
WINDING INNER DIA.	1 m
WINDING OUTER DIA.	1.66 m
WINDING WIDTH	0.17 m
No of TURNS	120
SELF-INDUCTANCE	22.6 mH
No of COOLING PATHS	4
TEST VOLTAGE	19.8 kV
TEST PRESSURE	30 bar